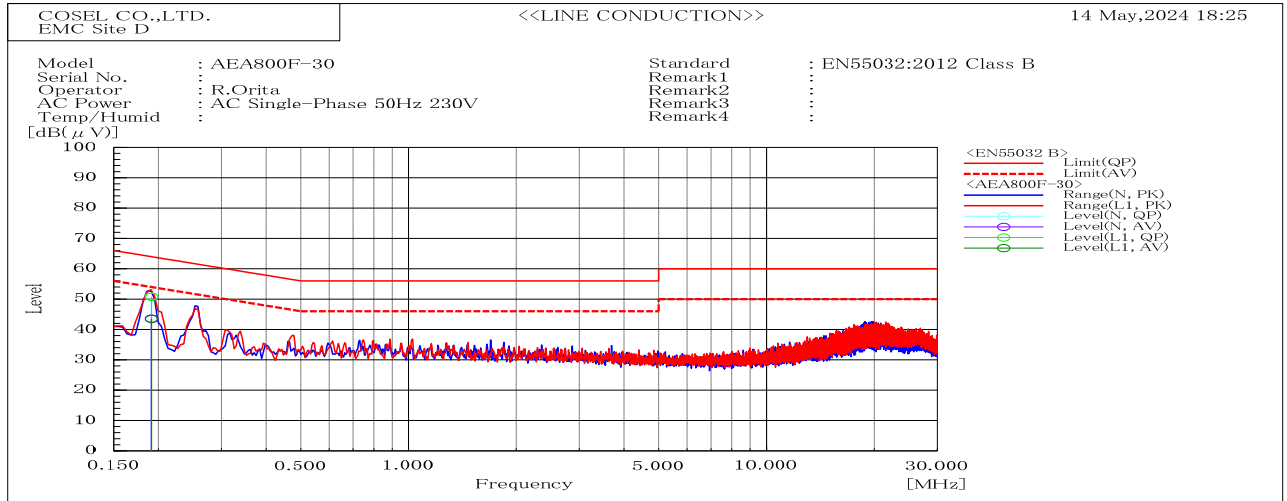
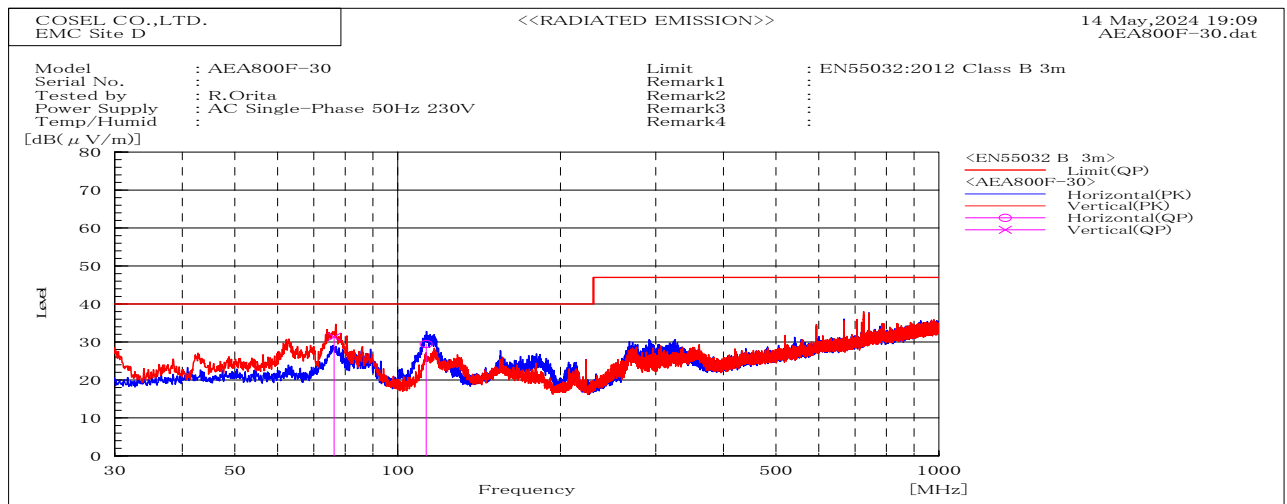


DATA SHEET			Date	17-Jun-24
Model	AEA800F-30		Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission		Humid.	40 %RH
			Tested by	R.Orita



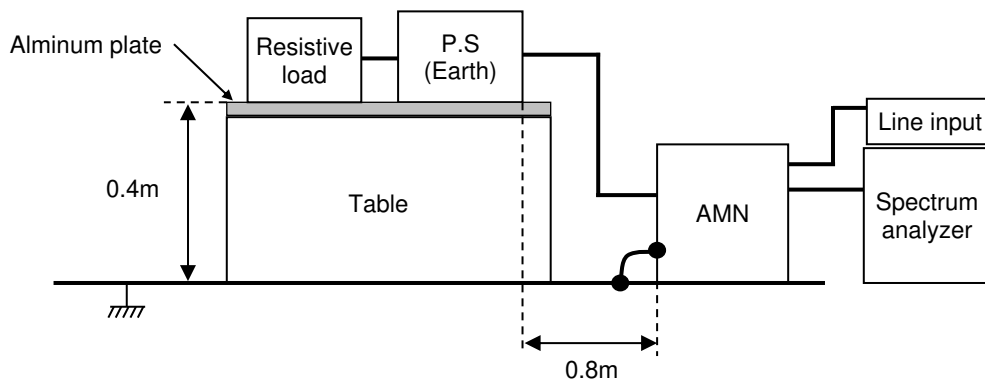
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.191	L1	50.8	43.5	64	54	13.2	10.5	Pass	
0.191	N	50.8	43.6	64	54	13.2	10.4	Pass	



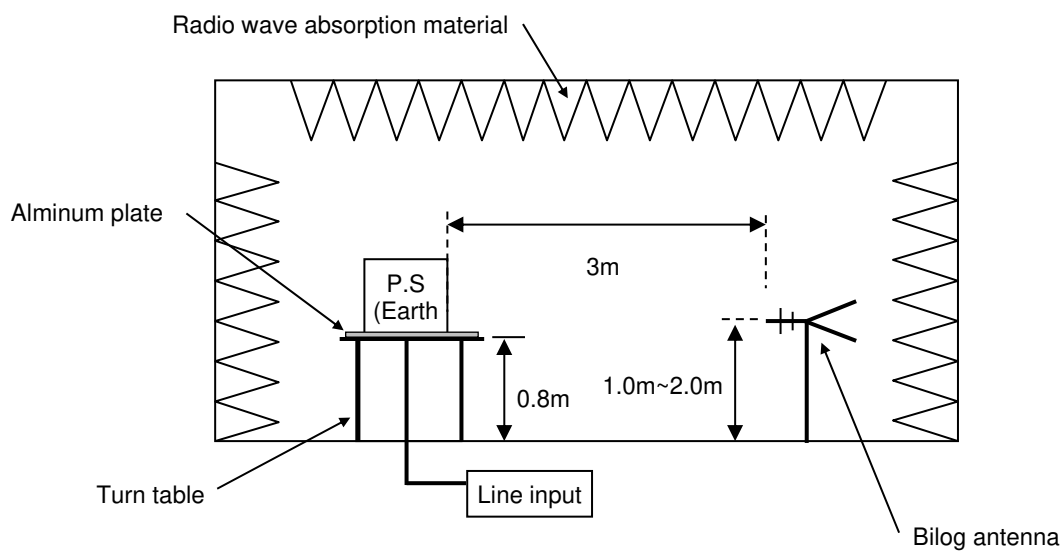
Frequency MHz	Polarization	Stability	Level dB(μV/m)	Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
76.322	V	Stable	31.3	40	8.7	Pass	100.3	353.7	
112.917	H	Stable	29.5	40	10.5	Pass	176	341.2	

DATA SHEET		Date	17-Jun-24
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	R.Orita

### 1. Line conduction



### 2. Radiated emission



## Conditions

Test : EMI  
Model Name: AEA800F-30

## Photographs of Test Set-Up

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

